

<b>Notice of References Cited</b>	Application/Control No. 09/926,529	Applicant(s)/Patent Under Reexamination YOSHIDA ET AL.	
	Examiner Dilek B. Cobanoglu	Art Unit 3626	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,454,721	10-1995	Kuch, Nina J.	434/127
*	B	US-2002/0120496	08-2002	Scroggie et al.	705/14
*	C	US-4,951,197	08-1990	Mellinger, Gilbert	600/300
*	D	US-6,040,531	03-2000	Miller-Kovach et al.	177/25.16
*	E	US-5,673,691	10-1997	Abrams et al.	600/300
*	F	US-6,618,062	09-2003	Brown et al.	715/822
*	G	US-2001/0025279	09-2001	Krulak et al.	707/3
*	H	US-2002/0048455	04-2002	TAMURA et al.	396/18
*	I	US-5,639,471	06-1997	Chait et al.	424/439
*	J	US-4,650,218	03-1987	Hawke, Earle M.	283/67
*	K	US-2001/0018671	08-2001	Ogasawara, Nobuo	705/26
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.